Search	<b>Notes</b>



Application/Control No.	Applicant(s)/Patent under Reexamination
10/797,010	INOUE, SHIGERU
Examiner	Art Unit
Frank Vanaman	3618

SEARCHED			
Class	Subclass	Date	Examiner
180	170, 171, 178, 179	5/23/2006	FBV
74	513	5/23/2006	FBV
701	93	5/23/2006	FBV

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY	)
	DATE	EXMR
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